

<IGBT Modules>

# CM450DX-24S1

HIGH POWER SWITCHING USE **INSULATED TYPE** 



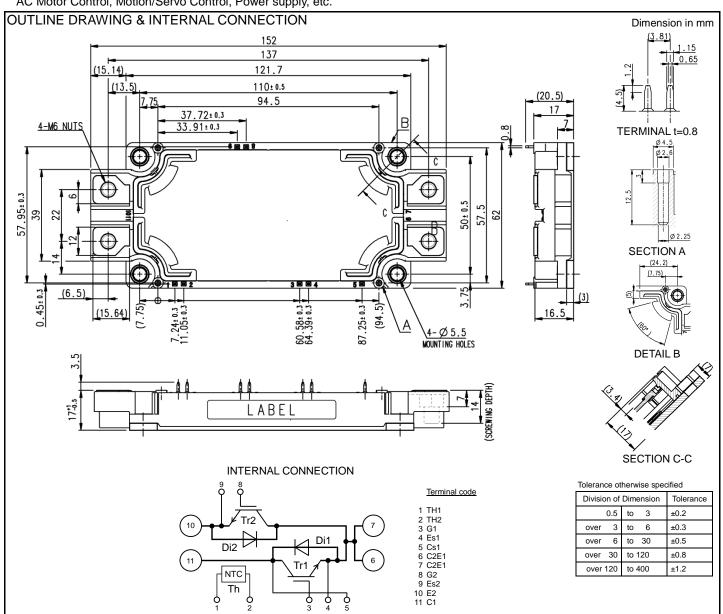
dual switch (Half-Bridge)

Collector current I<sub>C</sub> ...... 450A Maximum junction temperature T<sub>jmax</sub> .....

- •Flat base Type
- Copper base plate (non-plating)
- •Tin plating pin terminals
- •RoHS Directive compliant
- •Recognized under UL1557, File E323585

#### **APPLICATION**

AC Motor Control, Motion/Servo Control, Power supply, etc.



Ver.1.1

1

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**INSULATED TYPE** 

## MAXIMUM RATINGS (T<sub>j</sub>=25 °C, unless otherwise specified)

#### INVERTER PART IGBT/DIODE

Symbol	Item	Conditions	Rating	Unit
V <sub>CES</sub>	Collector-emitter voltage	G-E short-circuited	1200	V
V <sub>GES</sub>	Gate-emitter voltage	C-E short-circuited	± 20	V
Ic	Collector ourrent	DC, T <sub>C</sub> =107 °C (Note2, 4)	450	^
I <sub>CRM</sub>	- Collector current	Pulse, Repetitive (Note3)	900	Α
P <sub>tot</sub>	Total power dissipation	T <sub>C</sub> =25 °C (Note2, 4)	2775	W
I <sub>E</sub> (Note1)	Conitton ourrent	DC (Note2)	450	^
I <sub>ERM</sub> (Note1)	Emitter current	Pulse, Repetitive (Note3)	900	Α

#### MODULE

Symbol	Item	Conditions	Rating	Unit
V <sub>isol</sub>	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	4000	V
T <sub>jmax</sub>	Maximum junction temperature	Instantaneous event (overload)	175	°C
T <sub>Cmax</sub>	Maximum case temperature	(Note4)	125	
T <sub>jop</sub>	Operating junction temperature	Continuous operation (under switching)	-40 ~ +150	°C
T <sub>stg</sub>	Storage temperature	-	-40 ~ +125	

## ELECTRICAL CHARACTERISTICS (T<sub>j</sub>=25 °C, unless otherwise specified)

## INVERTER PART IGBT/DIODE

Symbol	Item	Conditions			Limits		Unit
Symbol	item Conditions			Min.	Тур.	Max.	Offic
I <sub>CES</sub>	Collector-emitter cut-off current	V <sub>CE</sub> =V <sub>CES</sub> , G-E short-circuited		ı	-	1.0	mA
I <sub>GES</sub>	Gate-emitter leakage current	V <sub>GE</sub> =V <sub>GES</sub> , C-E short-circuited		1	-	0.5	μA
V <sub>GE(th)</sub>	Gate-emitter threshold voltage	$I_C$ =45 mA, $V_{CE}$ =10 V		5.4	6.0	6.6	V
.,		I <sub>C</sub> =450 A, V <sub>GE</sub> =15 V,	T <sub>j</sub> =25 °C	-	1.80	2.25	
V <sub>CEsat</sub> (Terminal)		Refer to the figure of test circuit	T <sub>j</sub> =125 °C	-	2.00	-	V
(Terminal)	Collector-emitter saturation voltage	(Note5)	T <sub>j</sub> =150 °C	-	2.05	-	
.,	Collector-entitler saturation voltage	I <sub>C</sub> =450 A,	T <sub>j</sub> =25 °C	-	1.70	2.15	
V <sub>CEsat</sub>		V <sub>GE</sub> =15 V,	T <sub>j</sub> =125 °C	-	1.90	-	V
(Chip)		(Note5)	T <sub>j</sub> =150 °C	-	1.95	-	
Cies	Input capacitance			-	-	45	
Coes	Output capacitance	V <sub>CE</sub> =10 V, G-E short-circuited		-	-	9.0	nF
Cres	Reverse transfer capacitance	7		-	-	0.75	1
Q <sub>G</sub>	Gate charge	V <sub>CC</sub> =600 V, I <sub>C</sub> =450 A, V <sub>GE</sub> =15 V		-	945	-	nC
t <sub>d(on)</sub>	Turn-on delay time	V 000 V I 450 A V 45 V		-	-	800	
tr	Rise time	$V_{CC}$ =600 V, $I_{C}$ =450 A, $V_{GE}$ =±15 V,	-	-	200	1	
t <sub>d(off)</sub>	Turn-off delay time	<b>_</b>		-	-	600	ns
t <sub>f</sub>	Fall time	$R_{G}=0 \Omega$ , Inductive load		-	-	300	1
(Note1)		Refer to the figure of test circuit $T_j=125$ °C	T <sub>j</sub> =25 °C	-	2.60	3.40	V
V <sub>EC</sub> (Note1)			T <sub>j</sub> =125 °C	-	2.16	-	
(Terminal)			T <sub>j</sub> =150 °C	-	2.10	-	
(Noted)	Emitter-collector voltage	I <sub>E</sub> =450 A,	T <sub>j</sub> =25 °C	-	2.50	3.30	
V <sub>EC</sub> (Note1)		G-E short-circuited,	T <sub>j</sub> =125 °C	-	2.06	-	V
(Chip)			T <sub>j</sub> =150 °C	-	2.00	-	
t <sub>rr</sub> (Note1)	Reverse recovery time	V <sub>CC</sub> =600 V, I <sub>E</sub> =450 A, V <sub>GE</sub> =±15 V,	•	-	-	300	ns
Q <sub>rr</sub> (Note1)	Reverse recovery charge	R <sub>G</sub> =0 Ω, Inductive load		-	12	-	μC
Eon	Turn-on switching energy per pulse	V <sub>CC</sub> =600 V, I <sub>C</sub> =I <sub>E</sub> =450 A,		-	35.8	-	
E <sub>off</sub>	Turn-off switching energy per pulse	$V_{GE}=\pm 15 \text{ V}, R_{G}=0 \Omega, T_{i}=150 \text{ °C},$		-	52.4	-	mJ
E <sub>rr</sub> (Note1)	Reverse recovery energy per pulse	Inductive load		-	27.9	-	mJ
R <sub>CC'+EE'</sub>	Internal lead resistance	Main terminals-chip, per switch, T <sub>C</sub> =25 °C (Note2)		-	-	0.7	mΩ
r <sub>g</sub>	Internal gate resistance	Per switch		_	4.3	-	Ω

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### HIGH POWER SWITCHING USE

**INSULATED TYPE** 

#### ELECTRICAL CHARACTERISTICS (cont.; T<sub>i</sub>=25 °C, unless otherwise specified)

#### NTC THERMISTOR PART

Symbol	ltom	Conditions	Limits			Unit
	ltem ltem	Conditions	Min.	Тур.	Max.	Onit
R <sub>25</sub>	Zero-power resistance	T <sub>C</sub> =25 °C (Note4)	4.85	5.00	5.15	kΩ
ΔR/R	Deviation of resistance	R <sub>100</sub> =493 Ω, T <sub>C</sub> =100 °C (Note4)	-7.3	-	+7.8	%
B <sub>(25/50)</sub>	B-constant	Approximate by equation (Note6)	-	3375	-	K
P <sub>25</sub>	Power dissipation	T <sub>C</sub> =25 °C (Note4)	-	-	10	mW

#### THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Тур.	Max.	Offit
$R_{th(j-c)Q}$	Thermal resistance	Junction to case, per Inverter IGBT (Note4)	-	-	54	K/kW
$R_{th(j-c)D}$		Junction to case, per Inverter DIODE (Note4)	-	-	86	N/KVV
R <sub>th(c-s)</sub>	Contact thermal registeres	Case to heat sink, per 1 module,		15		K/kW
	Contact thermal resistance	Thermal grease applied (Note4, 7)	-	15	-	r/KVV

#### MECHANICAL CHARACTERISTICS

Symbol	Itom	Conditions		Limits			Unit
	Item			Min.	Тур.	Max.	Unit
$M_t$	Mounting torque	Main terminals	M 6 screw	3.5	4.0	4.5	N⋅m
Ms	Mounting torque	Mounting to heat sink	M 5 screw	2.5	3.0	3.5	N∙m
m	mass	-		-	350	-	g
ds	Creepage distance	Terminal to terminal		17	-	-	mm
u <sub>s</sub>		Terminal to base plate		18.5	-	-	
٦	Clearance	Terminal to terminal		10	-	-	mm
d <sub>a</sub>		Terminal to base plate		16.3	-	-	
ec	Flatness of base plate	On the centerline X, Y (Note8)		±0	-	+100	μm

Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free wheeling diode (DIODE)

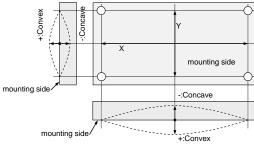
- 2. Junction temperature  $(T_j)$  should not increase beyond  $T_{jmax}$  rating.
- 3. Pulse width and repetition rate should be such that the device junction temperature  $(T_j)$  dose not exceed  $T_{jmax}$  rating.
- 4. Case temperature (T<sub>C</sub>) and heat sink temperature (T<sub>s</sub>) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.
- Pulse width and repetition rate should be such as to cause negligible temperature rise.

6. 
$$B_{(25/50)} = In(\frac{R_{25}}{R_{50}})/(\frac{1}{T_{25}} - \frac{1}{T_{50}})$$
,

 $R_{25}$ : resistance at absolute temperature  $T_{25}$  [K];  $T_{25}$ =25 [°C]+273.15=298.15 [K]

 $R_{50}$ : resistance at absolute temperature  $T_{50}$  [K];  $T_{50}$ =50 [°C]+273.15=323.15 [K]

- 7. Typical value is measured by using thermally conductive grease of  $\lambda$ =0.9 W/(m·K).
- 8. The base plate (mounting side) flatness measurement points (X, Y) are as follows of the following figure.



9. Use the following screws when mounting the printed circuit board (PCB) on the standoffs.

" $\phi$ 2.6×10 or  $\phi$ 2.6×12, B1 tapping screw"

The length of the screw depends on thickness (t1.6~t2.0) of the PCB.

#### HIGH POWER SWITCHING USE

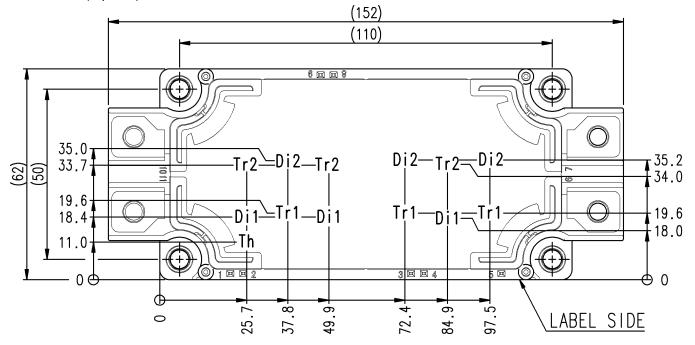
**INSULATED TYPE** 

#### RECOMMENDED OPERATING CONDITIONS

Symbol	Itom	Conditions	Limits			Unit
	Item	Conditions	Min.	Тур.	Max.	Offic
V <sub>CC</sub>	(DC) Supply voltage	Applied across C1-E2 terminals	-	600	850	V
$V_{GEon}$	Gate (-emitter drive) voltage	Applied across G1-Es1/G2-Es2 terminals	13.5	15.0	16.5	٧
$R_G$	External gate resistance	Per switch	0	-	10	Ω

#### CHIP LOCATION (Top view)

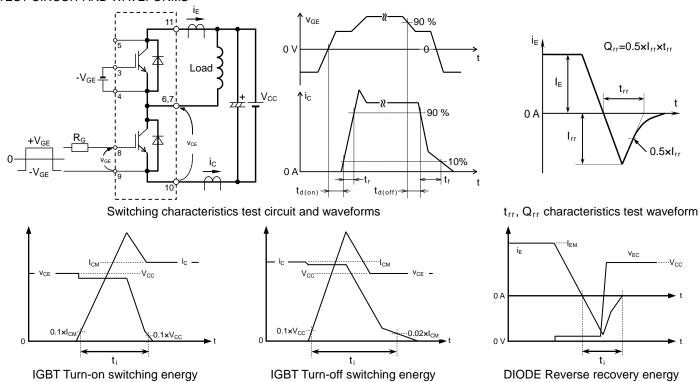
Dimension in mm, tolerance: ±1 mm



Tr1/Tr2: IGBT, Di1/Di2: DIODE, Th: NTC thermistor

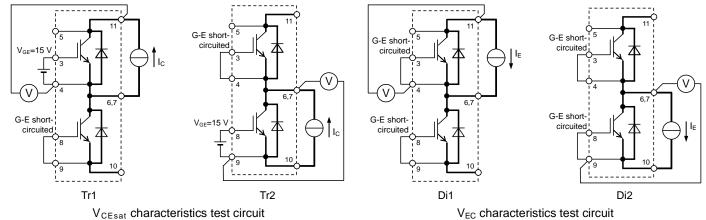
# HIGH POWER SWITCHING USE INSULATED TYPE

#### TEST CIRCUIT AND WAVEFORMS



Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

#### **TEST CIRCUIT**

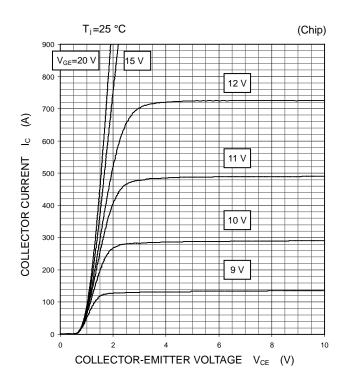


HIGH POWER SWITCHING USE INSULATED TYPE

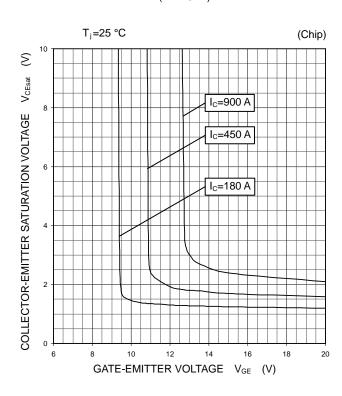
#### PERFORMANCE CURVES

**INVERTER PART** 

# OUTPUT CHARACTERISTICS (TYPICAL)

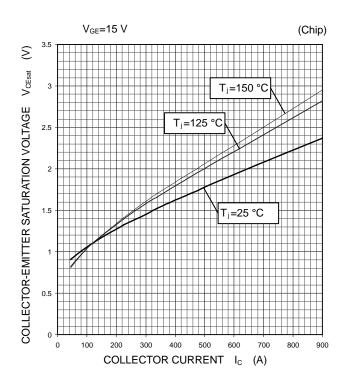


#### COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)

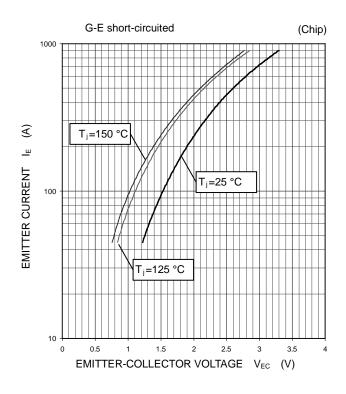


Ver.1.1

#### COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



#### FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)

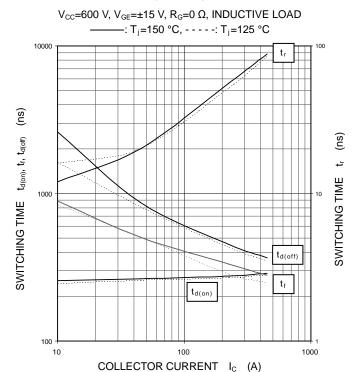


HIGH POWER SWITCHING USE INSULATED TYPE

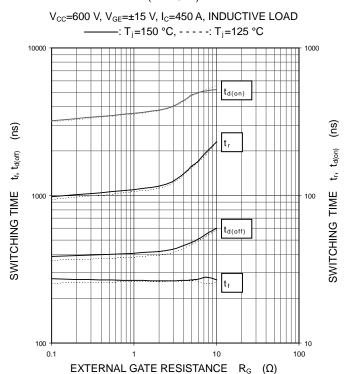
#### PERFORMANCE CURVES

#### **INVERTER PART**

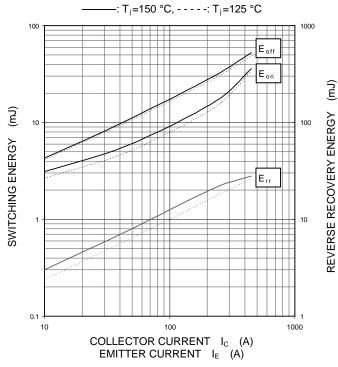
#### HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



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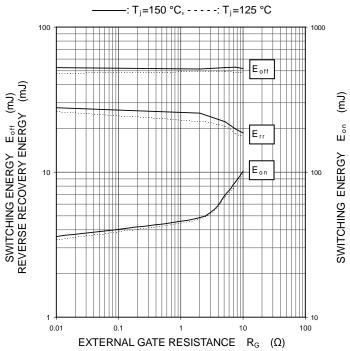


#### HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL) $V_{CC}=600 \text{ V}, V_{GE}=\pm15 \text{ V}, R_{G}=0 \Omega,$ INDUCTIVE LOAD, PER PULSE



Ver.1.1

# HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL) V<sub>CC</sub>=600 V, V<sub>GE</sub>=±15 V, I<sub>C</sub>/I<sub>E</sub>=450 A, INDUCTIVE LOAD, PER PULSE

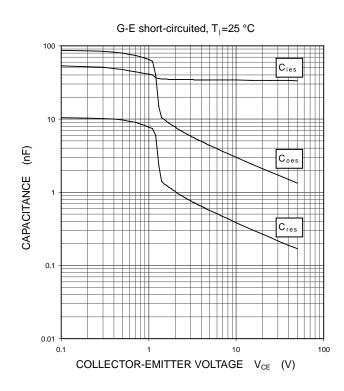


# HIGH POWER SWITCHING USE INSULATED TYPE

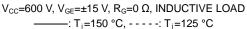
#### PERFORMANCE CURVES

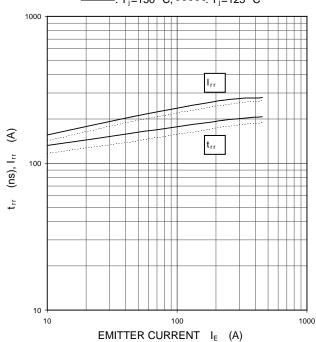
#### **INVERTER PART**

# CAPACITANCE CHARACTERISTICS (TYPICAL)

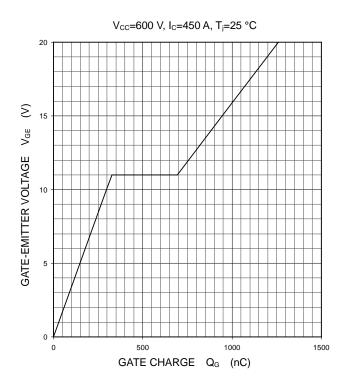


#### FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)





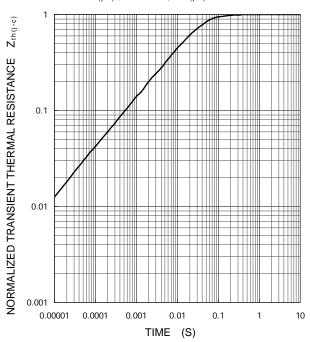
# GATE CHARGE CHARACTERISTICS (TYPICAL)



Ver.1.1

# TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)

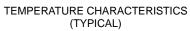
Single pulse,  $T_C=25$  °C  $R_{th(j-c)Q}=54$  K/kW,  $R_{th(j-c)D}=86$  K/kW

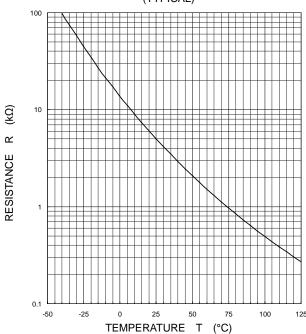


HIGH POWER SWITCHING USE INSULATED TYPE

## PERFORMANCE CURVES

NTC thermistor part





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HIGH POWER SWITCHING USE INSULATED TYPE

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